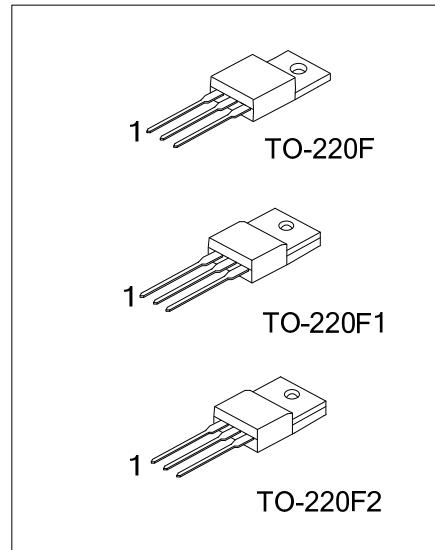


10N90-FC2

Power MOSFET

10A, 900V N-CHANNEL POWER MOSFET



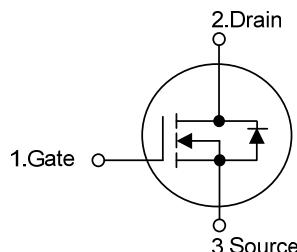
■ DESCRIPTION

The UTC **10N90-FC2** is a high voltage power MOSFET combines advanced trench MOSFET designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used in high speed switching applications of switching power supplies and adaptors.

■ FEATURES

- * $R_{DS(ON)} \leq 1.4 \Omega$ @ $V_{GS}=10V$, $I_D=5.0A$
- * Fast switching capability
- * Avalanche energy tested
- * Improved dv/dt capability, high ruggedness

■ SYMBOL



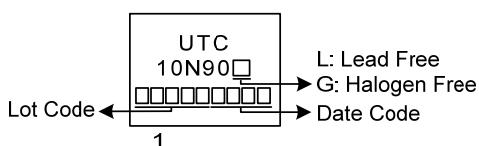
■ ORDERING INFORMATION

Ordering Number		Package	Pin Assignment			Packing
Lead Free	Halogen Free		1	2	3	
10N90L-TF1-T	10N90G-TF1-T	TO-220F1	G	D	S	Tube
10N90L-TF2-T	10N90G-TF2-T	TO-220F2	G	D	S	Tube
10N90L-TF3-T	10N90G-TF3-T	TO-220F	G	D	S	Tube

Note: Pin Assignment: G: Gate D: Drain S: Source

10N90G-TF1-T 	(1) T: Tube (2) TF1: TO-220F1, TF2: TO-220F2, TF3: TO-220F (3) G: Halogen Free and Lead Free, L: Lead Free
------------------	--

■ MARKING



■ ABSOLUTE MAXIMUM RATINGS ($T_c=25^\circ C$, unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT
Drain-Source Voltage	V_{DSS}	900	V
Gate-Source Voltage	V_{GSS}	± 30	V
Continuous Drain Current	I_D	10	A
Pulsed Drain Current (Note 2)	I_{DM}	20	A
Avalanche Energy Single Pulsed (Note 3)	E_{AS}	127	mJ
Peak Diode Recovery dv/dt (Note 4)	dv/dt	2	V/ns
Power Dissipation	P_D	38.5	W
Junction Temperature	T_J	+150	$^\circ C$
Storage Temperature	T_{STG}	-55 ~ +150	$^\circ C$

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. $L = 10mH$, $I_{AS} = 5.0A$, $V_{DD} = 100V$, $R_G = 25 \Omega$, Starting $T_J = 25^\circ C$

4. $I_{SD} \leq 10A$, $di/dt \leq 200A/\mu s$, $V_{DD} \leq BV_{DSS}$, Starting $T_J = 25^\circ C$

■ THERMAL DATA

PARAMETER	SYMBOL	RATING	UNIT
Junction to Ambient	θ_{JA}	62.5	$^\circ C/W$
Junction to Case	θ_{JC}	3.24	$^\circ C/W$

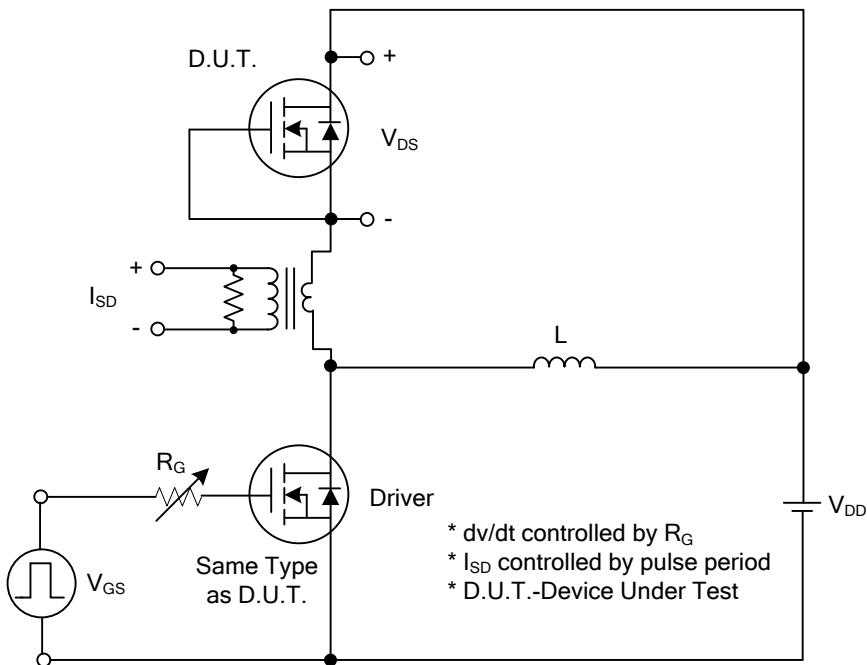
■ ELECTRICAL CHARACTERISTICS ($T_J=25^\circ C$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V$, $I_D=250\mu A$	900			V
Drain-Source Leakage Current	I_{DSS}	$V_{DS}=900V$, $V_{GS}=0V$			10	μA
Gate- Source Leakage Current	I_{GSS}	$V_{GS}=30V$, $V_{DS}=0V$			100	nA
		$V_{GS}=-30V$, $V_{DS}=0V$			-100	nA
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_D=250\mu A$	3.0		5.0	V
Static Drain-Source On-State Resistance	$R_{DS(ON)}$	$V_{GS}=10V$, $I_D=5.0A$			1.4	Ω
DYNAMIC CHARACTERISTICS						
Input Capacitance	C_{ISS}	$V_{DS}=25V$, $V_{GS}=0V$, $f=1.0MHz$		1820		pF
Output Capacitance	C_{OSS}			155		pF
Reverse Transfer Capacitance	C_{RSS}			2.1		pF
SWITCHING CHARACTERISTICS						
Total Gate Charge (Note 1)	Q_G	$V_{DS}=720V$, $V_{GS}=10V$, $I_D=10A$ $I_G=1mA$ (Note 1, 2)		34.2		nC
Gate-Source Charge	Q_{GS}			16.4		nC
Gate-Drain Charge	Q_{GD}			5		nC
Turn-On Delay Time (Note 1)	$t_{D(ON)}$	$V_{DS}=100V$, $V_{GS}=10V$, $I_D=10A$, $R_G=25\Omega$ (Note 1, 2)		37.8		ns
Turn-On Rise Time	t_R			18.33		ns
Turn-Off Delay Time	$t_{D(OFF)}$			64.5		ns
Turn-Off Fall Time	t_F			31.3		ns
DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS						
Maximum Body-Diode Continuous Current	I_S				10	A
Maximum Body-Diode Pulsed Current	I_{SM}				20	A
Drain-Source Diode Forward Voltage (Note 1)	V_{SD}	$I_S=10A$, $V_{GS}=0V$			1.4	V
Reverse Recovery Time (Note 1)	t_{rr}	$I_S=10A$, $V_{GS}=0V$ $di/dt=100A/\mu s$		576		ns
Reverse Recovery Charge	Q_{rr}			17		μC

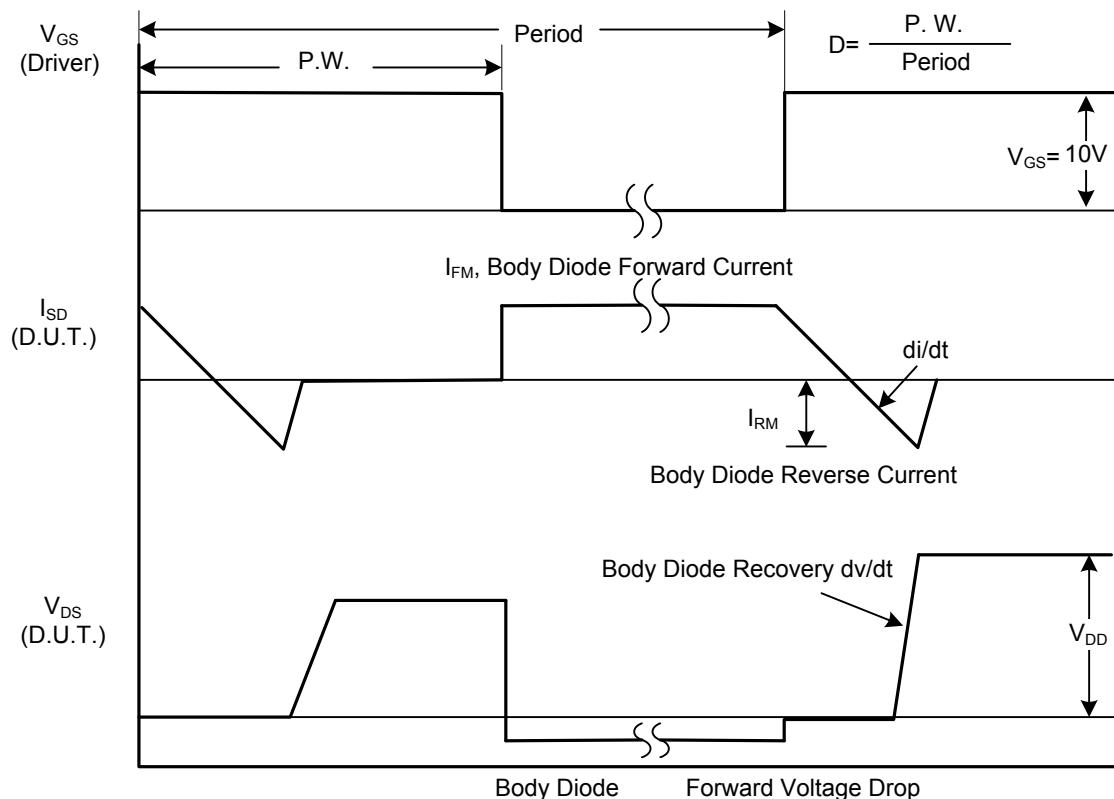
Notes: 1. Pulse Test: Pulse width $\leq 300\mu s$, Duty cycle $\leq 2\%$.

2. Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS

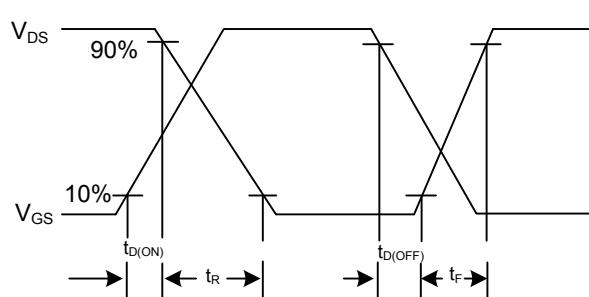
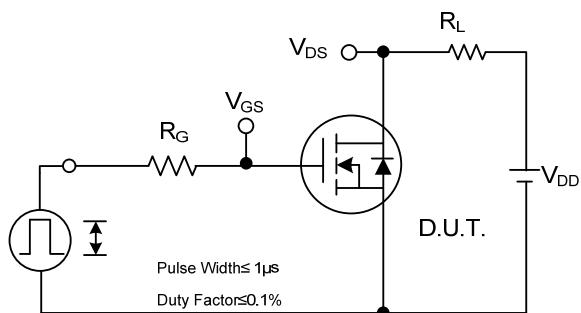


Peak Diode Recovery dv/dt Test Circuit



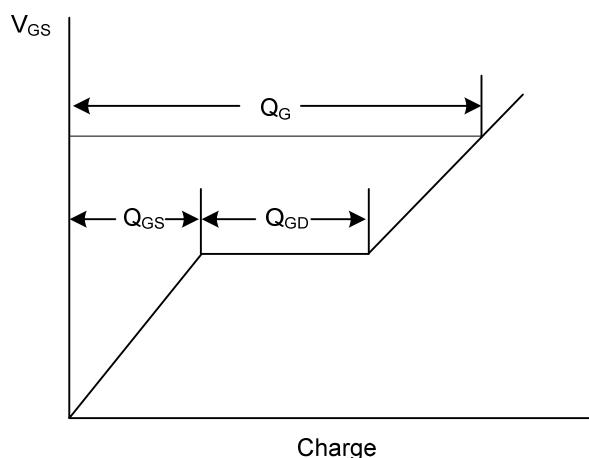
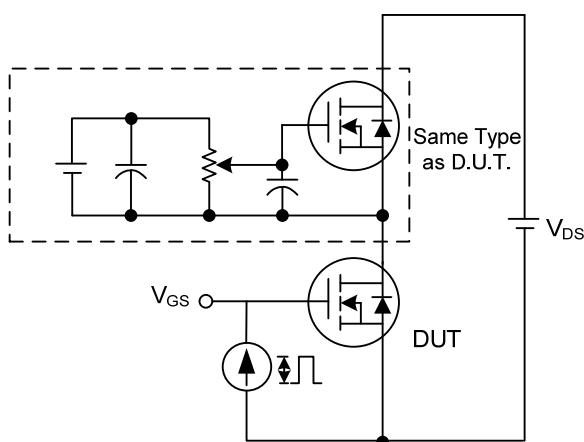
Peak Diode Recovery dv/dt Waveforms

■ TEST CIRCUITS AND WAVEFORMS



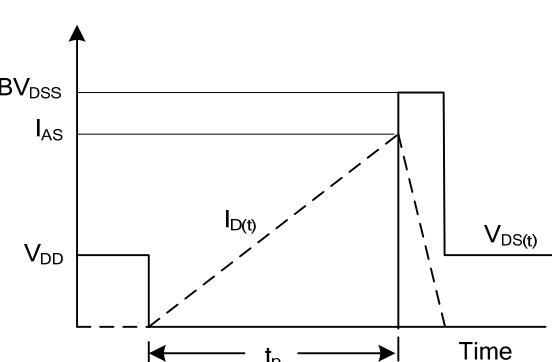
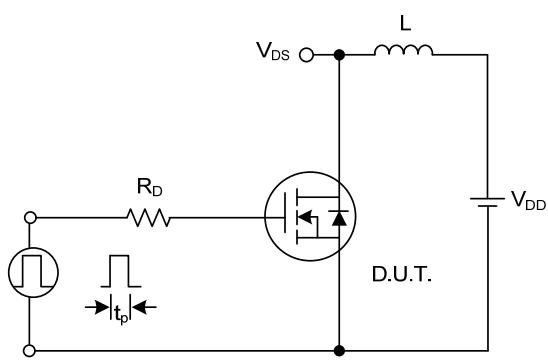
Switching Test Circuit

Switching Waveforms



Gate Charge Test Circuit

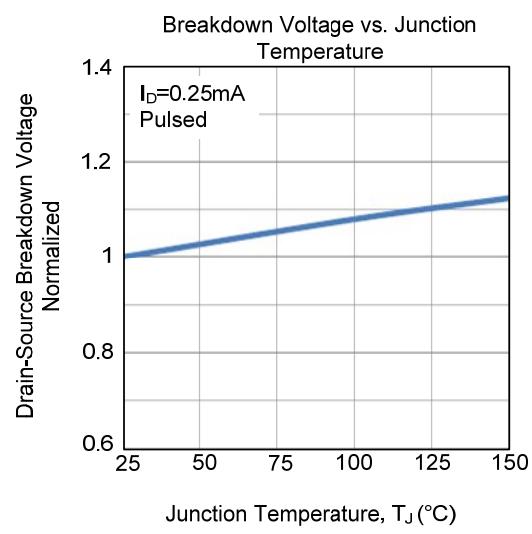
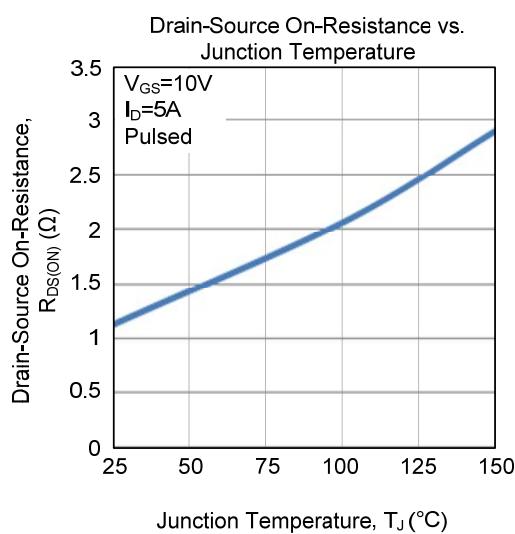
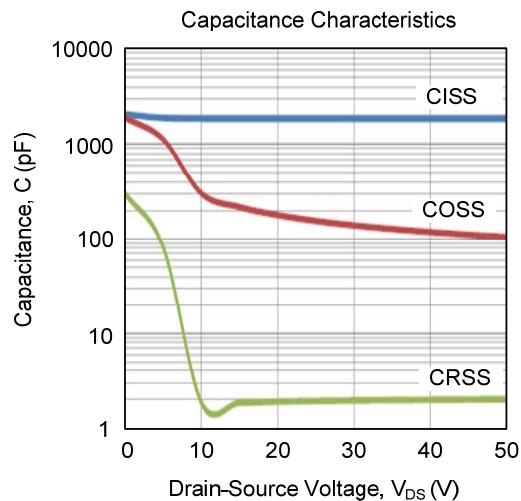
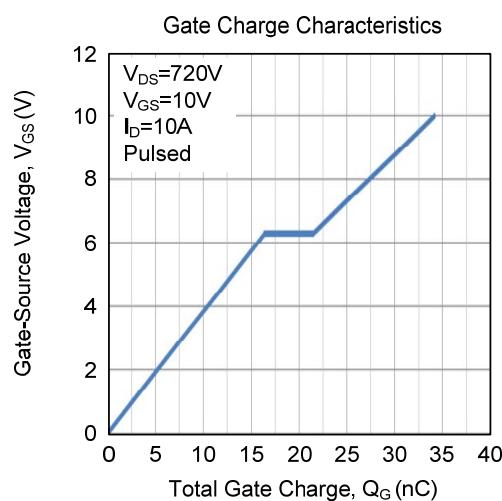
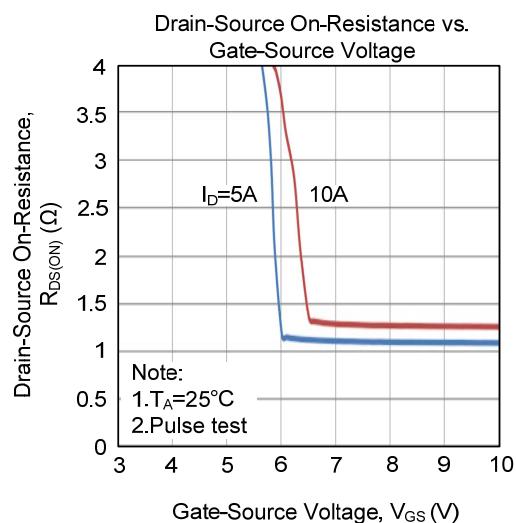
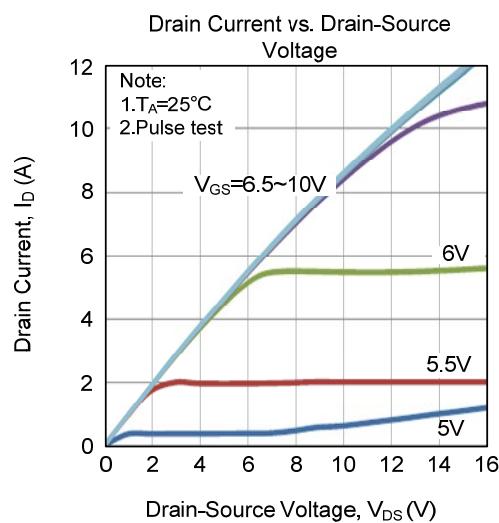
Gate Charge Waveform



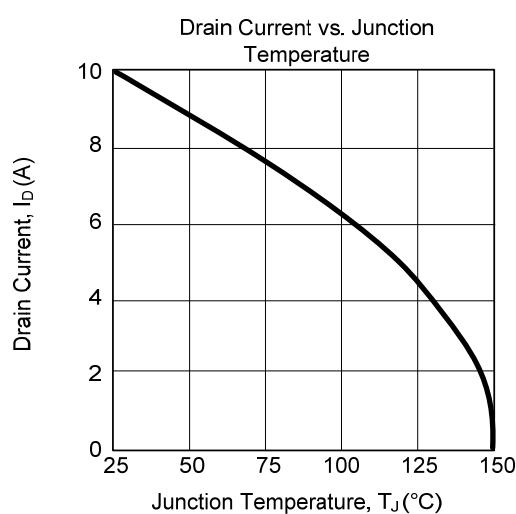
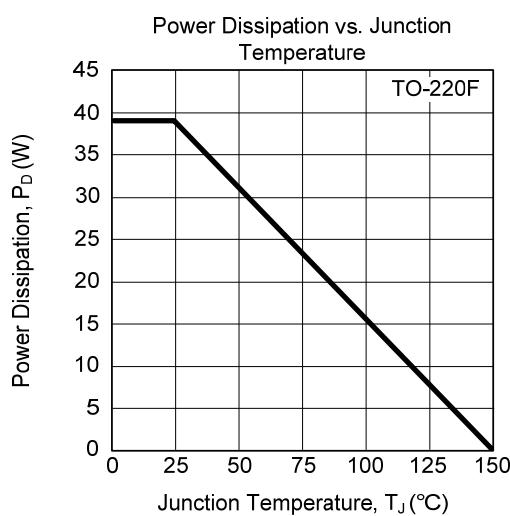
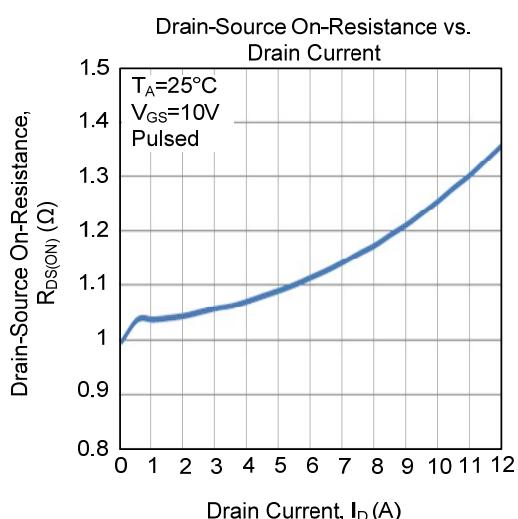
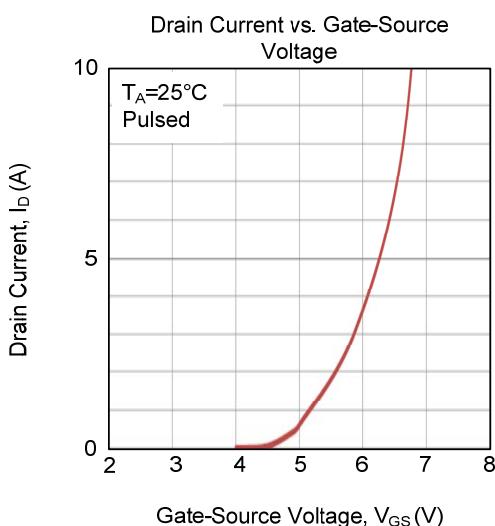
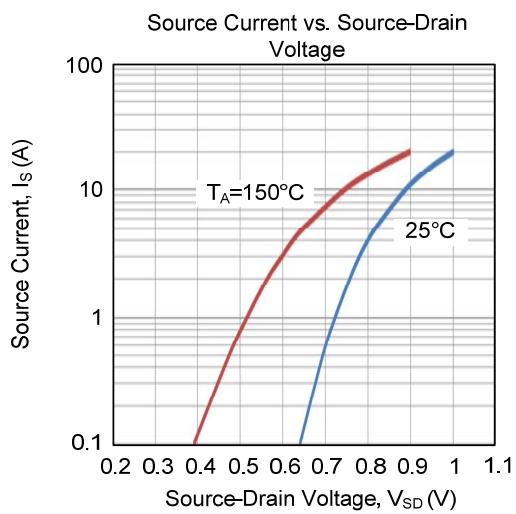
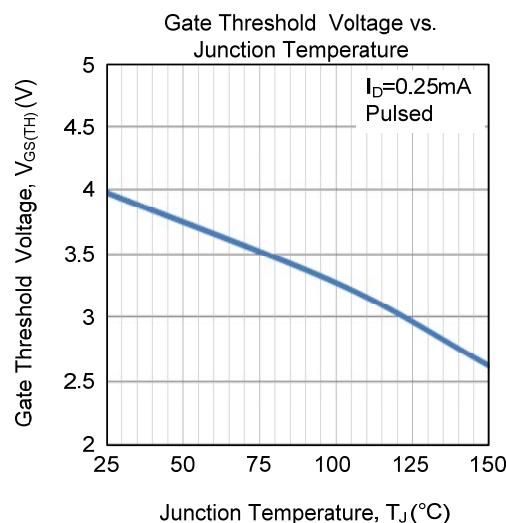
Unclamped Inductive Switching Test Circuit

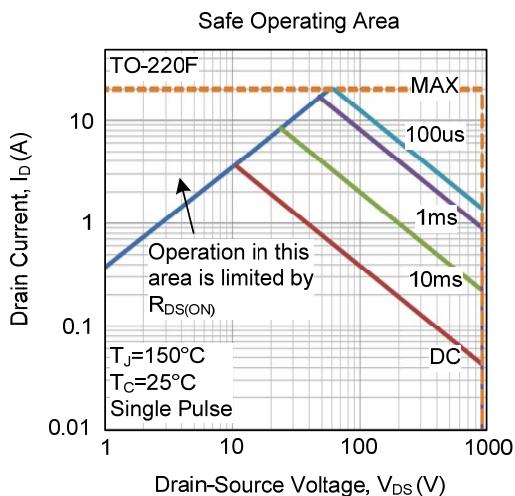
Unclamped Inductive Switching Waveforms

■ TYPICAL CHARACTERISTICS



■ TYPICAL CHARACTERISTICS (Cont.)



■ TYPICAL CHARACTERISTICS (Cont.)

UTC assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all UTC products described or contained herein. UTC products are not designed for use in life support appliances, devices or systems where malfunction of these products can be reasonably expected to result in personal injury. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner. UTC reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.